Applicant(s)/Patent Under Application/Control No. Reexamination 10/573,696 LEIMBACH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2886 Jonathan M. Hansen **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Wolleschensky et al. US-2005/0006597 01-2005 250/458.1 US-В US-С US-D US-Ε US-F US-G USн US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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